

# **METHOD FOR MANUFACTURING BIT LINE STRUCTURE, METHOD FOR MANUFACTURING SEMICONDUCTOR STRUCTURE, AND SEMICONDUCTOR STRUCTURE**

## **ABSTRACT**

A method for manufacturing a bit line structure, a method for a semiconductor structure, and a semiconductor structure are provided. The method for manufacturing a bit line structure includes the following operations. A bit line conductive layer is formed on a surface of a semiconductor substrate, and the bit line conductive layer is partially located in a groove in the surface of the semiconductor substrate. A first protective layer is formed on surfaces of the bit line conductive layer and the semiconductor substrate. A first barrier layer is formed on a surface of the first protective layer. The surface of the first barrier layer is subjected with passivating treatment. A sacrificial layer is formed on the surface of the first barrier layer, and the sacrificial layer is provided with a filling part filled in the groove. A part, other than the filling part, of the sacrificial layer is cleaned and stripped by using an etching solution. The etching selectivity of the etching solution to the sacrificial layer relative to the first barrier layer is increased by performing passivating treatment on the first barrier layer, so that the conductive layer in the first barrier layer cannot be damaged when the sacrificial layer is cleaned and stripped by using the etching solution.

[Fig. 8]